

Abstracts

Characterization of Packaged Varactor Diodes

Y.S. Lee and W.J. Getsinger. "Characterization of Packaged Varactor Diodes." 1971 G-MTT International Microwave Symposium Digest of Technical Papers 71.1 (1971 [MWSYM]): 42-43.

A method is presented for determining true junction capacitance and resistance, and all package equivalent circuit element values of varactor diodes from measurements of total capacitance and microwave impedance with bias.

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